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*10665725

Application/Control No.

10665725

Examiner

JOHN F RAMIREZ

Applicant(s)/Patent Under Reexamination
LIEW ET AL.

Art Unit
3737

✓	Rejected
=	Allowed

-	Cancelled
÷	Restricted

N	Non-Elected
1	Interference

Α	Appeal
0	Objected

CLAIM		DATE										
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	8				-	-						
	9	N	N	N	N	N						
	10	N	N	N	N	N						
	11	-	-	-		-						
	12	V	·	V	√	·						
	13	V	·	V	V	V						
	14	N	N	N	N	N						
	15	N	N	N	N	N						
	16	N	N	N	N	N						
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	31	N	N	N	N	N						
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CLAIM			DATE										
Final	Original	02/27/2008	11/24/2008	08/25/2009	04/13/2010	12/11/2010		Т		Г			
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	59	-	-	-	-					1			
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CLAIM		DATE										
Final	Original	02/27/2008	11/24/2008	08/25/2009	04/13/2010	12/11/2010				Т		
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	68	-	-	-	-	-				\top		
	69	-	-	-	-	-				1		
	70	-	-	-	-	-						
	71											
	72	-										
	73	-										
	74	-										
	75	-		-	-	-				Т		
	76	-		-	-	-						
	77	-	-	-	-	-						
	78	-	-	-	-	-						
	79		-	-	-	-		i				
	80		-	-	-	-			1			
	81	-										
	82	-										
	83	-	-	-	-	-						
	84	-	-	-	-	-				T		
	85	-	-	-	-	-				T		
	86	-	-	-	-	-				T		
	87	-	-	-	-	-						
	88	-	-	-	-	-						
	89	V	1	V	V	·						
	90	V	1	·	1	✓						
	91	V	1	·	·	✓						
	92	· ·	1	·	1	✓						
	93	V	1	·	·	·				1		
	94	V	1	V	·	· ·				Т		
	95	· ·	1	V	·	V						
	96	· ·	1	V	·	V				T		
	97	· ·	1	V	·	V				T		
	98	1	1	1	1	<				1		

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0	Objected

CL	AIM	DATE									
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	104	V	·	V	V	✓					
	105	V	1	·	·	√					
	106	N	N	N	N	Ν					
	107	N	N	N	N	Ν					
	108	N	N	N	N	N					
	109	N	N	N	N	N					
	110	N	N	N	N	N					
	111	N	N	N	N	Ν					
	112	N	N	N	N	Ν					
	113	V	N	N	N	Ν					
	114	N	N	N	N	Ν					
	115	N	N	N	N	N					
	116	V	√	√	√	·			1		
	117	V	V	V	√	·					
	118	V	·	V	V	<					
	119	V	·	V	V	·					
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	121	V	·	V	·	V					
	122	V	·	V	V	V					
	123	V	·	_	·	·					
	124	V	V	_	V	·					
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	126	V	·	·	·	·					
	127	·	·	·	1	✓					
	128	V	·	·	·	✓					
	129	·	·	·	·	✓					
	130	V	·	·	·	✓			1		
	131	N	N	N	N	N					

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CLAIM DATE										
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Non-Elected

Appeal

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☐ Claims renumbered in the same order as presented by applicant ☐ CPA									☐ T.D. ☐ R.1.47		
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	170	N	N	N	N	N					
	171	N	N	N	N	N					
	172	N	N	N	N	N					
	173			·	1	V					
	174			N	N	N					
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	176			N	N	N					
	177			N	N	N					
	178			N	N	N					
	179			N	N	N					
	180			N	N	N					

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